Gantner

Measurement Module for Strain Gage and LVDT/RVDT

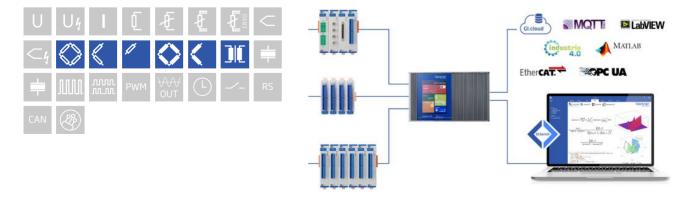
Q.raxx XL is a new addition to the Q.series product family - the ideal 19" rackmount DAQ solution for applications that require high channel density and custom sensor terminations. Q.raxx XL DAQ systems can utilize an integrated, high-performance controller for communication, control, and data logging purposes. With a controller, multiple Q.raxx XL systems can be synchronized to each other allowing for efficient DAQ distribution with low jitter and gradual expansion up to thousands of channels.

- High Density up to 13 I/O modules per Q.raxx 3U chassis with up to 16 channels per I/O module
- User Friendly front panel indicators for module status, power, and input range error
- Fully Customizable multiple front panel termination options available
- Maximum Flexibility parallel communication available in TCP/IP, CAN, PROFIBUS, Modbus, and EtherCAT
- Gantner's Quality Standard integrated filtering, galvanic isolation & signal/sensor conditioning per channel



Key Features

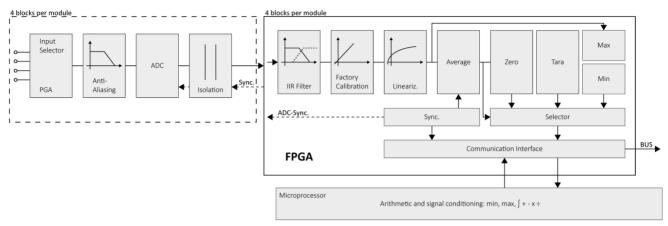
- 4 galvanically isolated analog inputs channels strain gage and inductive half and full bridges, LVDT, RVDT quarter bridge with completion terminal
- Carrier frequency (CF) principle
 4.8 kHz carrier frequency
- High-accuracy digitization
 24 bit ADU, 20 kHz sample rate per channel
- Signal conditioning linearization, filtering, average, scaling, min/max, RMS, arithmetic, alarm
- 3-Way galvanic isolation
 500 VDC channel to channel, channel to power supply, and channel to bus





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Block diagram



Technical Data

Analog Input

| Channels | 4 |
|-------------------|--|
| Accuracy | 0.02 % typical |
| | 0.05 % in controlled environment ¹ |
| | 0.1 % in industrial area ² |
| Linearity error | 0.02 % typical full-scale |
| Repeatability | 0.01 % typical (within 24 hrs) |
| Input impedance | >10 MΩ |
| Isolation voltage | 500 VDC channel to channel, to power supply, channel to bus ³ |

 $^{\rm 1}\,$ according to EN 61326 2006: appendix B

² according to EN 61326 2006: appendix A

 $^{\rm 3}\,$ noise pulses up to 1000 VDC, continuous up to 250 VDC

Measurement Module for Strain Gage and LVDT/RVDT



Strain Gage Measurement

| Bridge configuration(s) | resistive full-bridge (4/w resistive half-bridge (3/w | | |
|------------------------------------|--|----------------------------|--|
| Allowable sensor cable length | < 30 m | | |
| Shunt resistor | 100 kΩ internal resistor | | |
| Bridge excitation | 2.5 or 5 Veff, 4.8 kHz AC e | excitation | |
| Bridge excitation stability | <0.01% / 24 hrs | | |
| Bridge excitation drift | <0.02% / 10 K | | |
| | 5 Veff | 2.5 Veff | |
| Allowable sensor resistance | >300 Ω | >100 Q | |
| Input range | ±1.25 mV/V | ±2.5 mV/V | |
| | ±2.5 mV/V | ±5 mV/V | |
| | ±25 mV/V | ±50 mV/V | |
| | ±50 mV/V | ±100 mV/V | |
| | ±100 mV/V | ±200 mV/V | |
| | ±200 mV/V | ±400 mV/V | |
| | ±500 mV/V | ±1000 mV/V | |
| Long-term stability | < 0.1 µV/V / 24 hrs | <1 µV/V / 8000 hrs | |
| Temperature drift (range 2.5 mV/V) | <0.2 µV/V / 10 K Offset drift | < 0.05 % / 10 K Gain drift | |
| Signal-to-noise ratio | <0.3 µV/V at 10 Hz | <1 µV/V at 100 Hz | |

LVDT/RVDT Measurement

| Sensor connection | 3- / 4-wire | |
|------------------------------------|-------------------------------|----------------------------|
| Sensor excitation (selectable) | 5 Veff | 2.5 Veff |
| Allowable sensor resistance | >300 Ω | >100 Q |
| Input range | ±1.25 mV/V | ±2.5 mV/V |
| | ±2.5 mV/V | ±5 mV/V |
| | ±25 mV/V | ±50 mV/V |
| | ±50 mV/V | ±100 mV/V |
| | ±100 mV/V | ±200 mV/V |
| | ±200 mV/V | ±400 mV/V |
| | ±250 mV/V | ±500 mV/V |
| | ±500 mV/V | ±1000 mV/V |
| Allowable sensor cable length | <100 m ¹ | |
| Long-term stability | <0.1 µV/V / 24 hrs | <1 µV/V / 8000 hrs |
| Temperature drift (range 2.5 mV/V) | <0.2 µV/V / 10 K Offset drift | < 0.05 % / 10 K Gain drift |
| Signal-to-noise ratio | <0.3 µV/V at 10 Hz | <1 µV/V at 100 Hz |

¹ low capacity sensor cable is strongly recommended

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Analog-to-Digital Conversion

| Resolution | 24-bit |
|----------------------|---|
| Sample rate | 20 kHz per channel |
| Modulation method | sigma-delta |
| Anti-aliasing filter | 1 kHz, 3th order (4.8 kHz CF excitation) |
| Digital filters | Infinite impulse response (IIR), low-pass, high-pass, band-pass, band-stop, Butterworth or Bessel (2nd, 4th, 6th or 8th order), frequency range 0.1 Hz to 1 kHz in steps of 0.1 (adjustable via software) |
| Averaging | configurable or automatic according to the user-defined data rate |

Communication Interface Localbus

| Protocols | proprietary Localbus (115200 bps to 48 Mbps, latency <100 ns) ASCII (19200 bps to 115200 bps) Modbus RTU |
|---------------------|--|
| Data format | 8E1 |
| Electrical standard | ANSI/TIA/EIA-485-A, 2-wire |

Power Supply

| Input voltage | 10 to 30 VDC, overvoltage and overcurrent protection |
|-------------------------|--|
| Power consumption | 2.5 W (approx.) |
| Input voltage influence | <0.001 % / V |

Environmental Specifications

| Electromagnetic compatibility (EMC) | according to IEC 61000-4 and EN 55011 |
|-------------------------------------|---------------------------------------|
| Operating temperature | -20°C to +60°C |
| Storage temperature | -40°C to +85°C |
| Relative humidity | 5 - 95 % at 50°C (non-condensing) |

Remarks

| Validity of all listed specifications are subject to a warm-up period of at least 45 minutes | |
|--|--|
| Specifications subject to change without notice | |

Mechanical information

| Material | Aluminum |
|--------------------------|-----------------|
| Measurements (W x H x D) | 30x 128 x 120mm |
| Weight | approx. 200 g |

Ordering Information

Article number 675935

Measurement Module for Strain Gage and LVDT/RVDT



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